

**GL Silicon N-Channel Super-Junction Power MOSFET**
**General Description :**

GL20J60AN the silicon N-channel Enhanced VDMOSFETS, is obtained by the self-aligned Super-junction Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-3P(N), which accords with the RoHS standard.

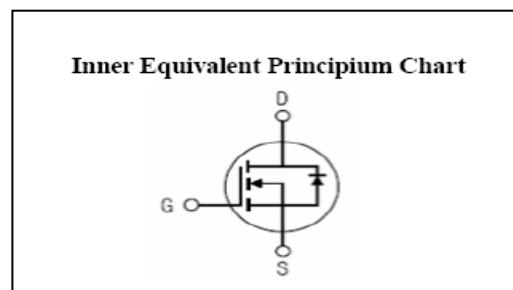
$V_{DSS}$	600	V
$I_D$	20	A
$P_D(T_C=25^\circ C)$	166	W
$R_{DS(ON)}TYP$	0.12	$\Omega$


**Features :**

- Fast Switching
- Low Gate Charge and  $R_{ds(on)}$
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

**Applications :**

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply(UPS)
- Power Factor Correction(PFC)


**Absolute (  $T_c = 25^\circ C$  unless otherwise specified ):**

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	600	V
$I_D$	Continuous Drain Current	20	A
$I_{DM}^{a1}$	Pulsed Drain Current	60	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 30$	V
$E_{AS}^{a2}$	Single Pulse Avalanche Energy	532	mJ
$P_D$	Power Dissipation	166	W
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	150, -55 to 150	°C
$T_L$	Maximum Temperature for Soldering	300	°C

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

**Thermal Characteristics**

Symbol	Parameter	Typ.	Units
$R_{\theta JC}$	Junction-to-Case	0.75	°C/W
$R_{\theta JA}$	Junction-to-Ambient	55	°C/W



# GL20J60AN

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## GL Silicon N-Channel Super-Junction Power MOSFET

**Electrical Characteristics** (  $T_c=25^\circ\text{C}$  unless otherwise specified ) :

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	600	--	--	V
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=600\text{V}, V_{GS}=0\text{V}, T_a= 25^\circ\text{C}$	--	--	1.0	$\mu\text{A}$
		$V_{DS}=480\text{V}, V_{GS}=0\text{V}, T_a=150^\circ\text{C}$	--	--	250	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS} = +30\text{V}$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS} = -30\text{V}$	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}^{a3}$	Drain-to-Source On-Resistance	$V_{GS}=10\text{V}, I_D=10\text{A}$	--	0.12	0.15	$\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.0	--	3.0	V

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$g_{fs}^{a3}$	Forward Transconductance	$V_{DS}=10\text{V}, I_D=20\text{A}$	--	18.8	--	S
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_D=25\text{V}$	--	1600	--	$\text{pF}$
$C_{oss}$	Output Capacitance	$f=1.0\text{MHz}$	--	14	--	
$C_{rss}$	Reverse Transfer Capacitance		--	225	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD}=300\text{V}, I_D=20\text{A}, V_{GS}=10\text{V} R_g=25\Omega$	--	48	--	ns
$t_r$	Rise Time		--	108	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	176	--	
$t_f$	Fall Time		--	50	--	
$Q_g$	Total Gate Charge	$I_D = 20\text{A}, V_{DD}=480\text{V}$	--	41	--	nC
$Q_{gs}$	Gate to Source Charge		--	8	--	
$Q_{gd}$	Gate to Drain ( "Miller" )Charge		--	15	--	

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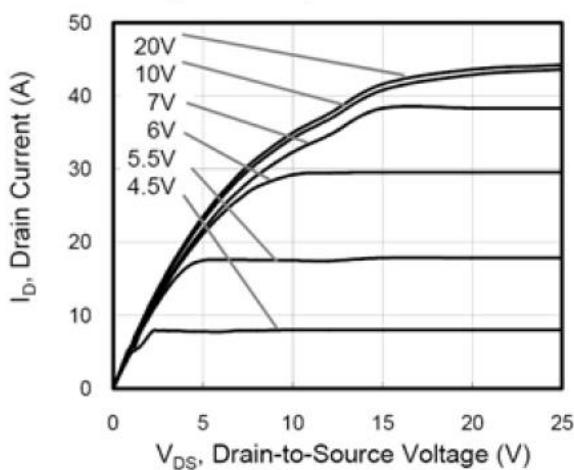
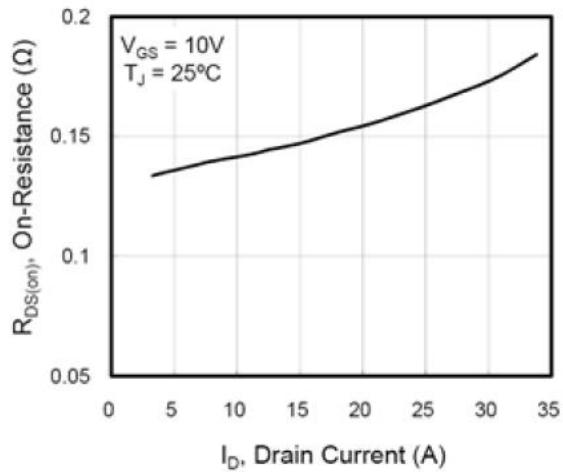
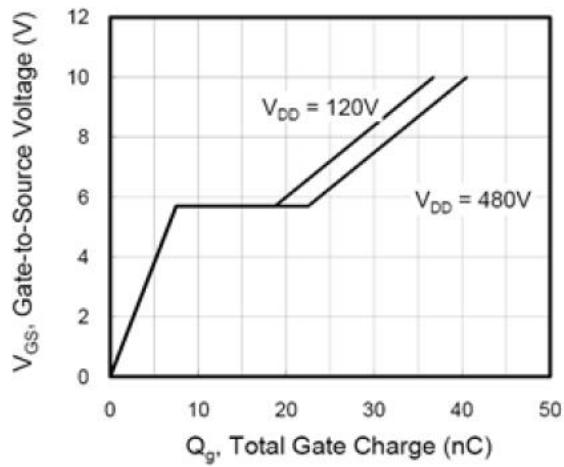
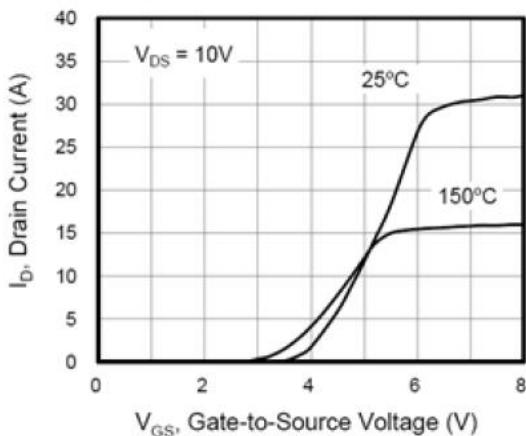
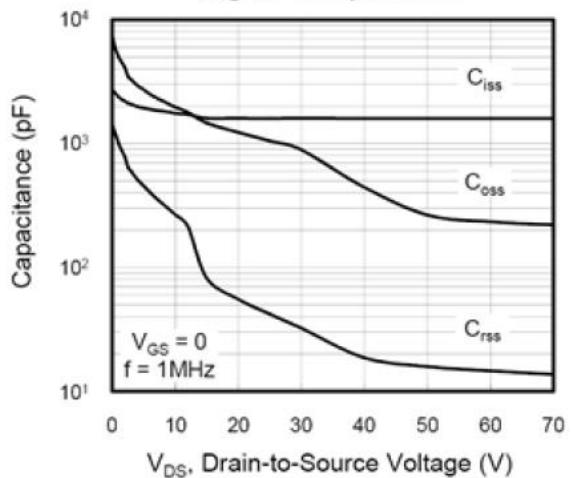
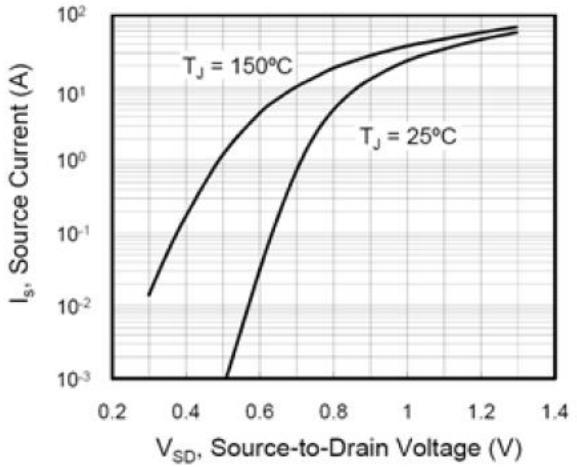
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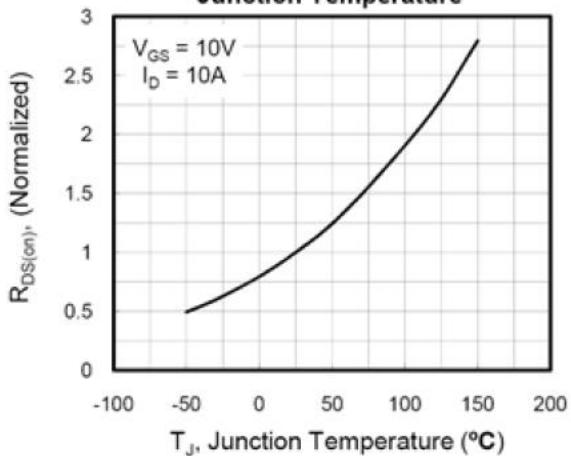
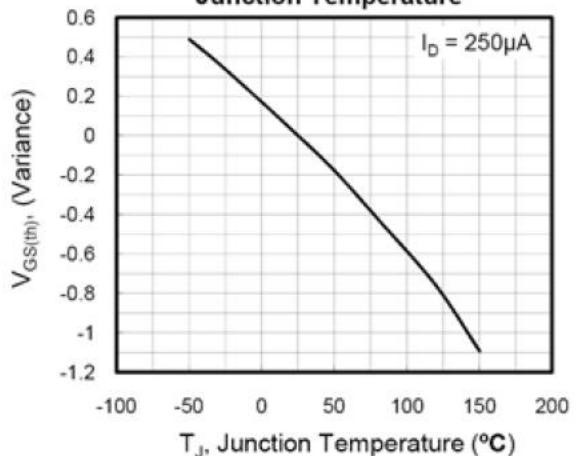
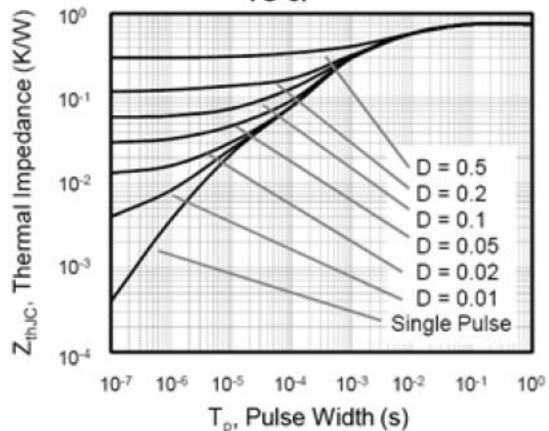
**GL Silicon N-Channel Super-Junction Power MOSFET****Source-Drain Diode Characteristics**

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I <sub>S</sub>	Continuous Source Current (Body Diode)		--	--	20	A
I <sub>SM</sub>	Maximum Pulsed Current (Body Diode)		--	--	60	A
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =20A, V <sub>GS</sub> =0V	--	--	1.5	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =20A, V <sub>GS</sub> =0V	--	440	--	ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>S</sub> =I <sub>F</sub> , dI/dt=100A/us	--	5.0	--	uC

Pulse width tp≤380μs, δ≤2%

<sup>a1</sup> : Repetitive rating; pulse width limited by maximum junction temperature<sup>a2</sup> : I<sub>AS</sub>=10A, V<sub>DD</sub>=50V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>= 25°C<sup>a3</sup> : Pulse Test: Pulse width≤380us, Duty Cycle≤2%

**GL Silicon N-Channel Super-Junction Power MOSFET**
**Typical Characteristics**
**Figure 1. Output Characteristics**

**Figure 3. On-Resistance vs. Drain Current**

**Figure 5. Gate Charge**

**Figure 2. Transfer Characteristics**

**Figure 4. Capacitance**

**Figure 6. Body Diode Forward Voltage**


**GL Silicon N-Channel Super-Junction Power MOSFET**
**Figure 7. On-Resistance vs. Junction Temperature**

**Figure 8. Threshold Voltage vs. Junction Temperature**

**Figure 9. Transient Thermal Impedance TO-3P**


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